

Application/Control No.	Applicant(s)/Patent under Reexamination
09/901,502	KOO ET AL.
Examiner	Art Unit

Shick C. Hom

2666

SEARCHED						
Class	Subclass	Date	Examiner			
	updated search	2/3/2006	SH			
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INI	INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
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